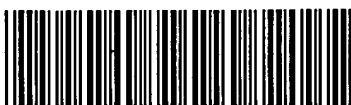


Search Notes

Application/Control No.

10/670,579

Examiner

Ly D. Pham

Applicant(s)/Patent under
Reexamination

LEE, CHANG HYUK

Art Unit

2827

SEARCHED

Class	Subclass	Date	Examiner
365	203	6/15/2005	LP
	191		
	189.08		
	214		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	6/15/2005	LP